

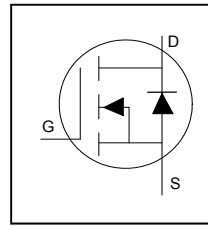
### Application

- Brushed motor drive applications
- BLDC motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC inverters

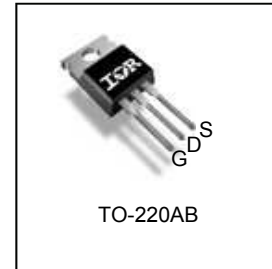
### Benefits

- Improved gate, avalanche and dynamic dV/dt ruggedness
- Fully characterized capacitance and avalanche SOA
- Enhanced body diode dV/dt and dI/dt capability
- Lead-free, RoHS compliant

HEXFET® Power MOSFET



|                   |              |
|-------------------|--------------|
| $V_{DSS}$         | <b>60V</b>   |
| $R_{DS(on)}$ typ. | <b>4.9mΩ</b> |
|                   | <b>max</b>   |
| $I_D$             | <b>95A</b>   |



|          |          |          |
|----------|----------|----------|
| <b>G</b> | <b>D</b> | <b>S</b> |
| Gate     | Drain    | Source   |

| Base part number | Package Type | Standard Pack |          | Orderable Part Number |
|------------------|--------------|---------------|----------|-----------------------|
|                  |              | Form          | Quantity |                       |
| IRFB7545PbF      | TO-220       | Tube          | 50       | IRFB7545PbF           |

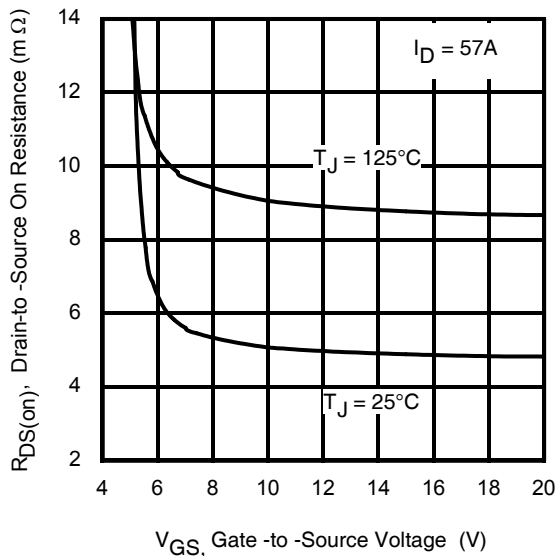


Fig 1. Typical On-Resistance vs. Gate Voltage

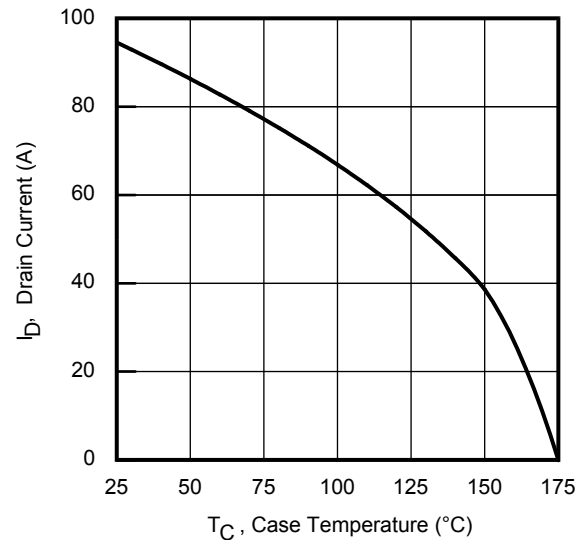


Fig 2. Maximum Drain Current vs. Case Temperature

**Absolute Maximum Rating**

| Symbol                          | Parameter   | Max.                | Units |
|---------------------------------|---|---------------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10\text{V}$         | 95                  | A     |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$         | 67                  |       |
| $I_{DM}$                        | Pulsed Drain Current ①                                  | 380                 |       |
| $P_D @ T_C = 25^\circ\text{C}$  | Maximum Power Dissipation                               | 125                 | W     |
|                                 | Linear Derating Factor                                  | 0.83                | W/°C  |
| $V_{GS}$                        | Gate-to-Source Voltage                                  | $\pm 20$            | V     |
| $T_J$<br>$T_{STG}$              | Operating Junction and Storage Temperature Range        | -55 to + 175        | °C    |
|                                 | Soldering Temperature, for 10 seconds (1.6mm from case) | 300                 |       |
|                                 | Mounting Torque, 6-32 or M3 Screw                       | 10 lbf-in (1.1 N-m) |       |

**Avalanche Characteristics**

| Symbol                       | Parameter                       | Max.                     | Units |
|------------------------------|---------------------------------|--------------------------|-------|
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ② | 140                      | mJ    |
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ③ | 235                      |       |
| $I_{AR}$                     | Avalanche Current ①             | See Fig 15, 16, 23a, 23b | A     |
| $E_{AR}$                     | Repetitive Avalanche Energy ①   |                          | mJ    |

**Thermal Resistance**

| Symbol          | Parameter                          | Typ. | Max. | Units |
|-----------------|------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case ⑦                 | —    | 1.21 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat Greased Surface | 0.50 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient                | —    | 62   |       |

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

| Symbol                          | Parameter                            | Min. | Typ. | Max. | Units | Conditions   |
|---------------------------------|--------------------------------------|------|------|------|-------|--|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 60   | —    | —    | V     | $V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 46   | —    | mV/°C | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$                  |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 4.9  | 5.9  | mΩ    | $V_{GS} = 10\text{V}, I_D = 57\text{A}$                            |
|                                 |                                      | —    | 6.3  | —    |       | $V_{GS} = 6.0\text{V}, I_D = 29\text{A}$                           |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.1  | —    | 3.7  | V     | $V_{DS} = V_{GS}, I_D = 100\mu\text{A}$                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 1.0  | μA    | $V_{DS} = 60\text{V}, V_{GS} = 0\text{V}$                          |
|                                 |                                      | —    | —    | 150  |       | $V_{DS} = 60\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA    | $V_{GS} = 20\text{V}$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |       | $V_{GS} = -20\text{V}$   |
| $R_G$                           | Gate Resistance                      | —    | 2.3  | —    | Ω     |  |

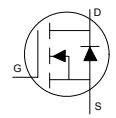
**Notes:**

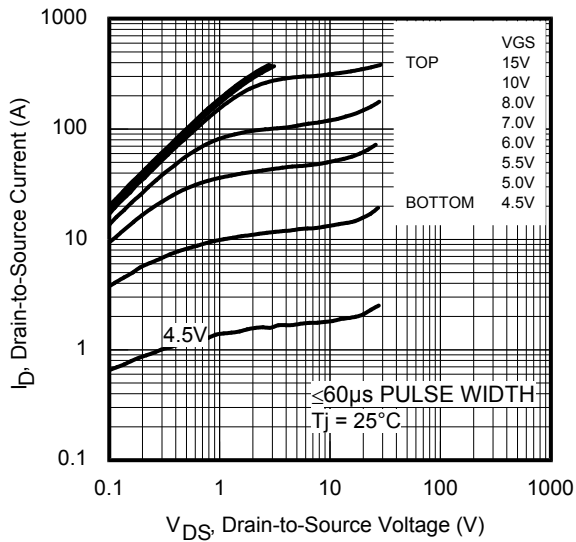
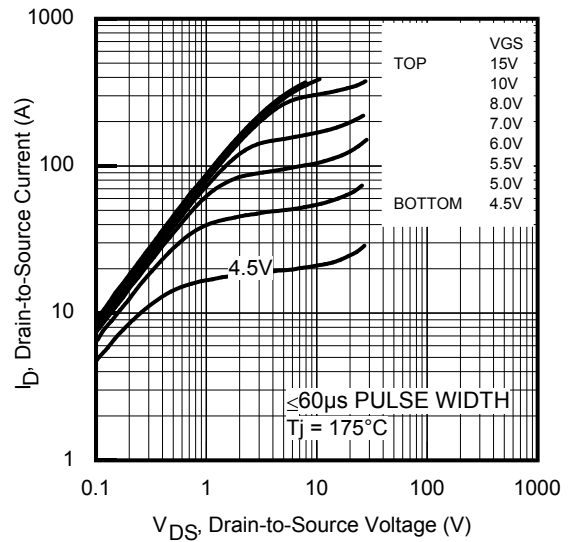
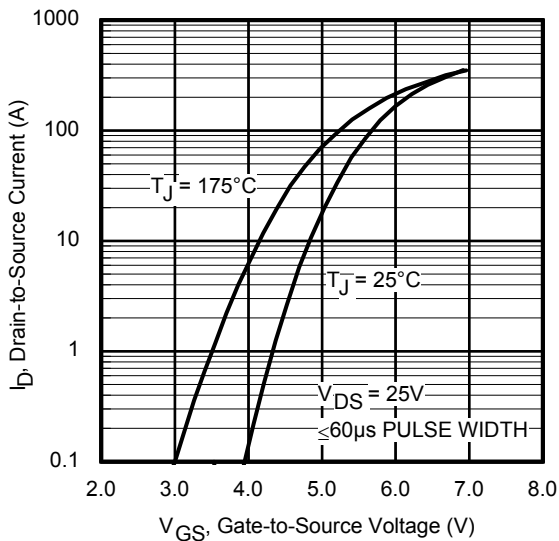
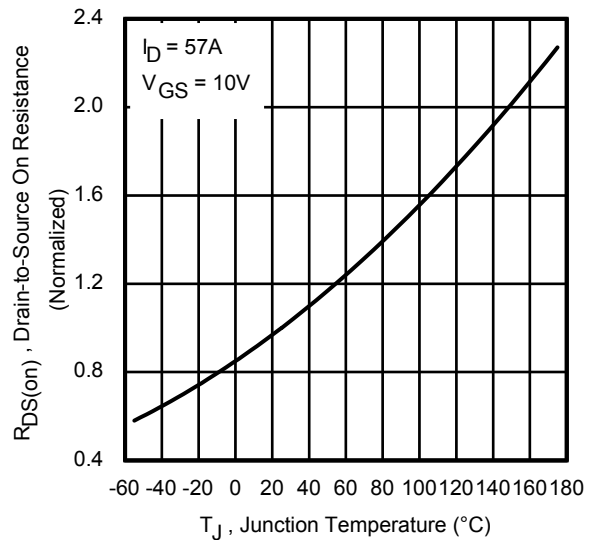
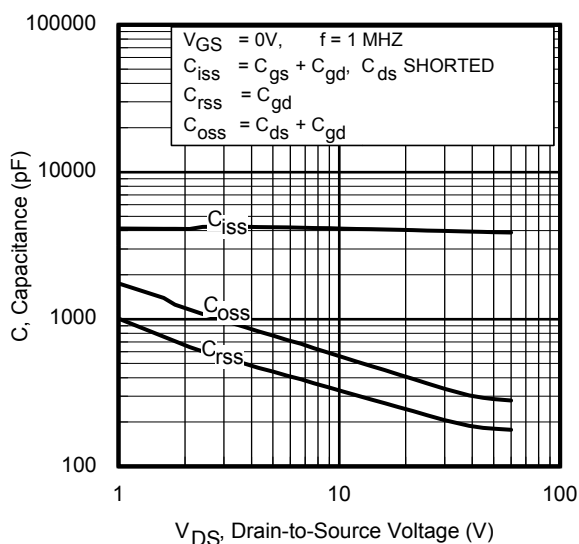
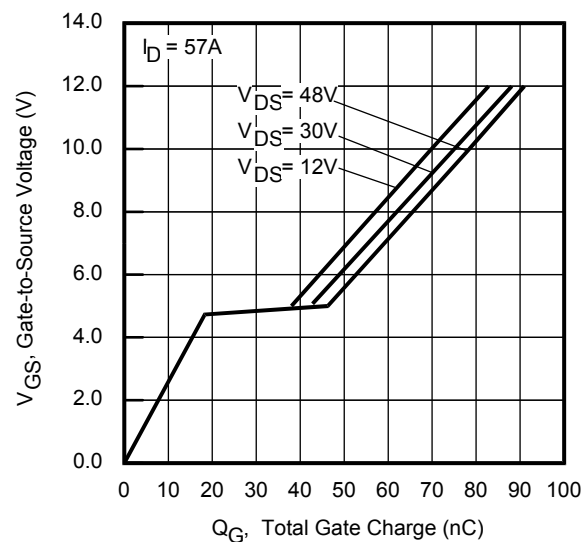
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 88\mu\text{H}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 57\text{A}$ ,  $V_{GS} = 10\text{V}$ .
- ③  $I_{SD} \leq 57\text{A}$ ,  $di/dt \leq 810\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175^\circ\text{C}$ .
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑥  $C_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑦  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .
- ⑧ Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 1\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 22\text{A}$ ,  $V_{GS} = 10\text{V}$ .

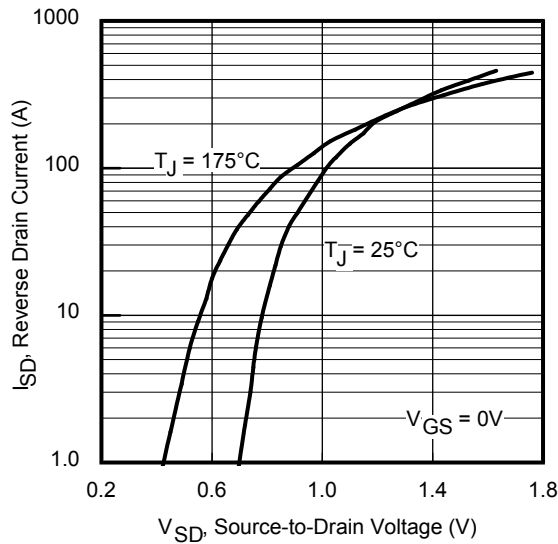
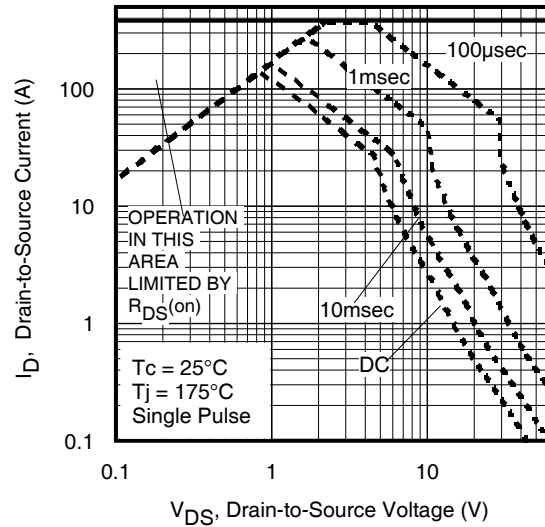
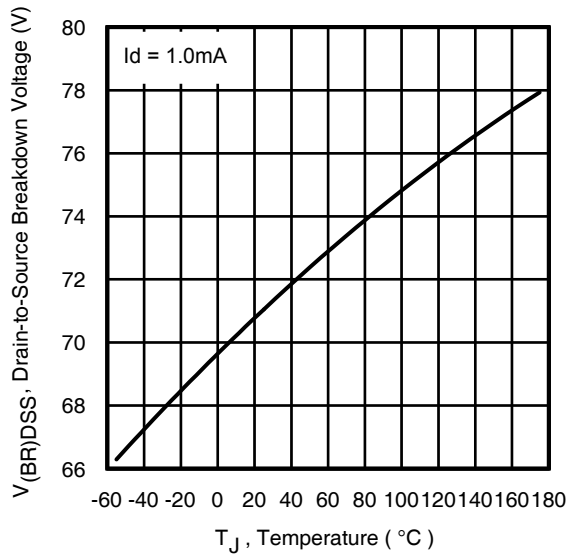
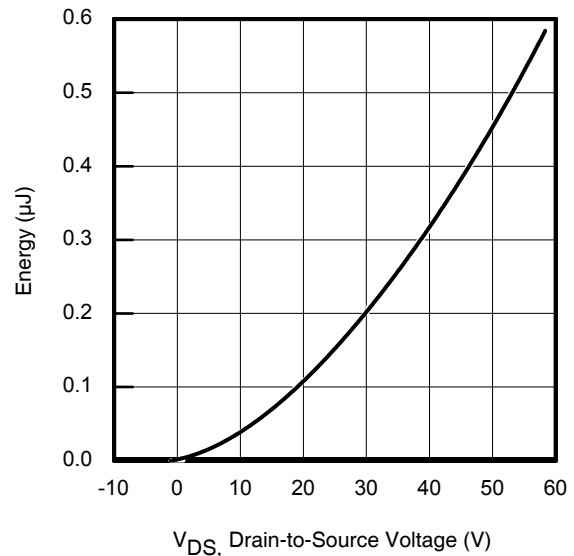
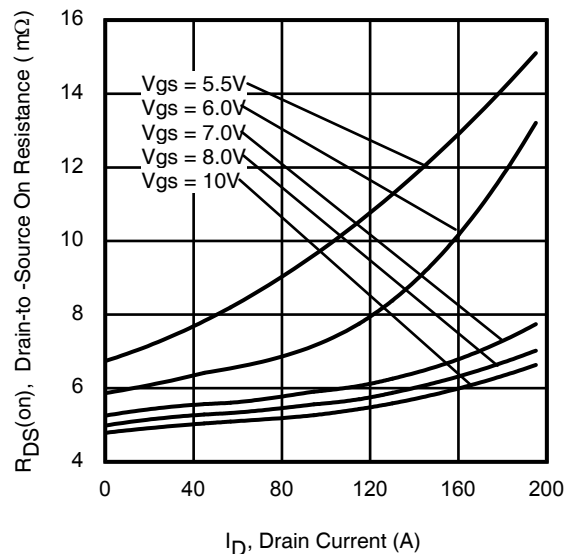
**Dynamic Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

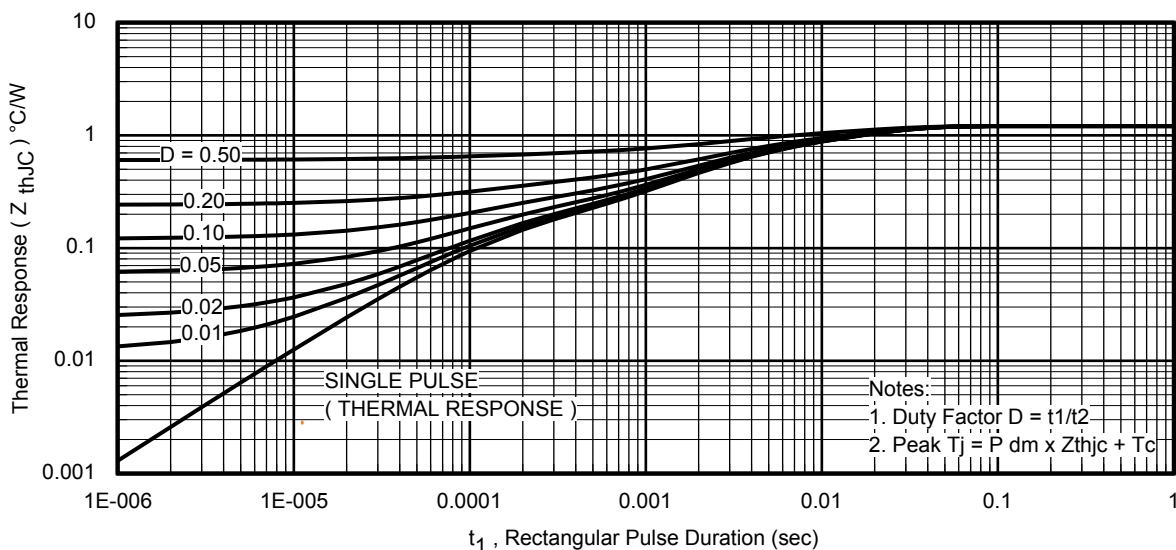
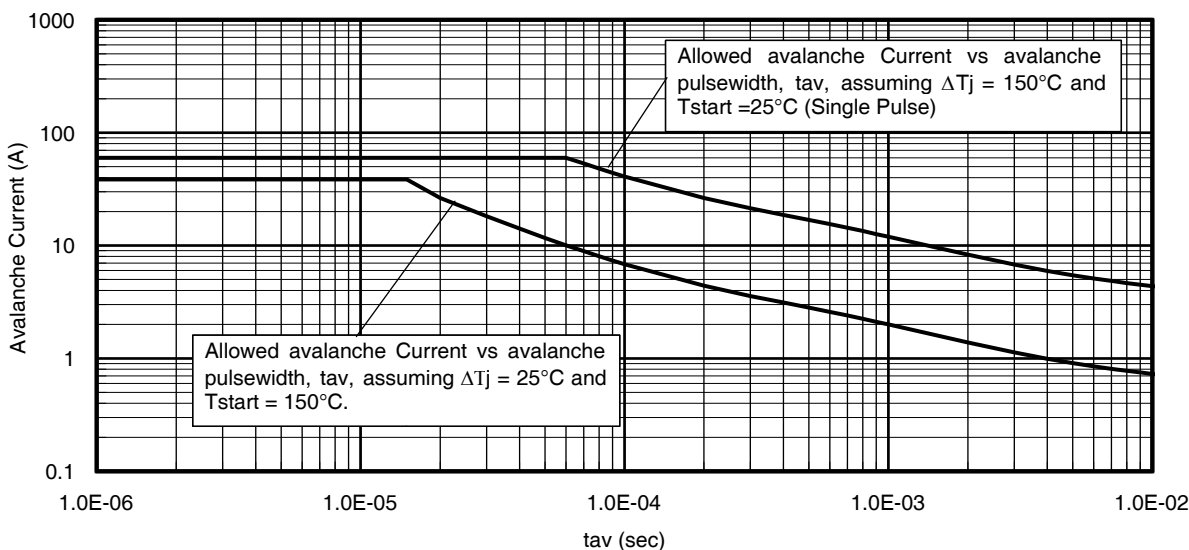
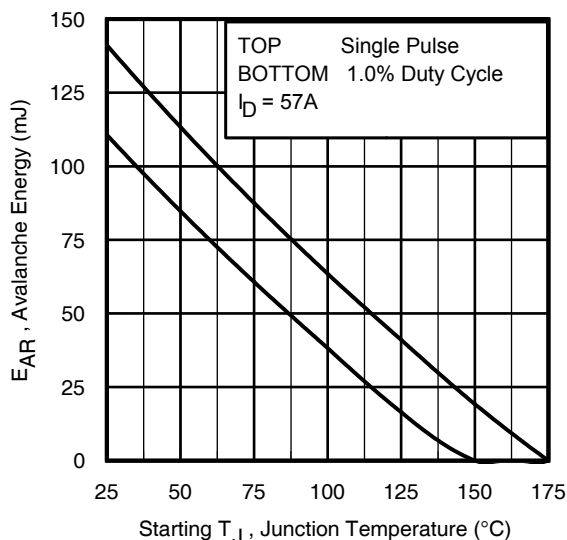
| Symbol              | Parameter                                     | Min. | Typ. | Max. | Units | Conditions  |
|---------------------|---|------|------|------|-------|---|
| gfs                 | Forward Transconductance                      | 90   | —    | —    | S     | $V_{DS} = 25\text{V}, I_D = 57\text{A}$   |
| $Q_g$               | Total Gate Charge                             | —    | 75   | 110  | nC    | $I_D = 57\text{A}$<br>$V_{DS} = 30\text{V}$<br>$V_{GS} = 10\text{V}$                        |
| $Q_{gs}$            | Gate-to-Source Charge                         | —    | 19   | —    |       |   |
| $Q_{gd}$            | Gate-to-Drain Charge                          | —    | 24   | —    |       |   |
| $Q_{sync}$          | Total Gate Charge Sync. ( $Q_g - Q_{gd}$ )    | —    | 32   | —    |       |   |
| $t_{d(on)}$         | Turn-On Delay Time                            | —    | 12   | —    | ns    | $V_{DD} = 30\text{V}$<br>$I_D = 57\text{A}$<br>$R_G = 2.7\Omega$<br>$V_{GS} = 10\text{V}$ ④ |
| $t_r$               | Rise Time                                     | —    | 72   | —    |       |   |
| $t_{d(off)}$        | Turn-Off Delay Time                           | —    | 44   | —    |       |   |
| $t_f$               | Fall Time                                     | —    | 43   | —    |       |   |
| $C_{iss}$           | Input Capacitance                             | —    | 4010 | —    | pF    | $V_{GS} = 0\text{V}$<br>$V_{DS} = 25\text{V}$<br>$f = 1.0\text{MHz}$ , See Fig.7            |
| $C_{oss}$           | Output Capacitance                            | —    | 370  | —    |       |   |
| $C_{riss}$          | Reverse Transfer Capacitance                  | —    | 230  | —    |       |   |
| $C_{oss\ eff.(ER)}$ | Effective Output Capacitance (Energy Related) | —    | 370  | —    |       |   |
| $C_{oss\ eff.(TR)}$ | Output Capacitance (Time Related)             | —    | 470  | —    |       |   |

**Diode Characteristics**

| Symbol    | Parameter                              | Min. | Typ. | Max. | Units | Conditions  |
|-----------|--|------|------|------|-------|---|
| $I_S$     | Continuous Source Current (Body Diode) | —    | —    | 95   | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$  | Pulsed Source Current (Body Diode) ①   | —    | —    | 380  |       |   |
| $V_{SD}$  | Diode Forward Voltage                  | —    | —    | 1.2  | V     | $T_J = 25^\circ\text{C}, I_S = 57\text{A}, V_{GS} = 0\text{V}$ ④  |
| dv/dt     | Peak Diode Recovery dv/dt              | —    | 12   | —    | V/ns  | $T_J = 175^\circ\text{C}, I_S = 57\text{A}, V_{DS} = 60\text{V}$ ③  |
| $t_{rr}$  | Reverse Recovery Time                  | —    | 33   | —    | ns    | $T_J = 25^\circ\text{C}$ $V_{DD} = 51\text{V}$<br>$T_J = 125^\circ\text{C}$ $I_F = 57\text{A}$ ,  |
|           |  | —    | 37   | —    |       |   |
| $Q_{rr}$  | Reverse Recovery Charge                | —    | 36   | —    | nC    | $T_J = 25^\circ\text{C}$ $di/dt = 100\text{A}/\mu\text{s}$ ④<br>$T_J = 125^\circ\text{C}$   |
|           |  | —    | 48   | —    |       |   |
| $I_{RRM}$ | Reverse Recovery Current               | —    | 2.0  | —    | A     | $T_J = 25^\circ\text{C}$  |

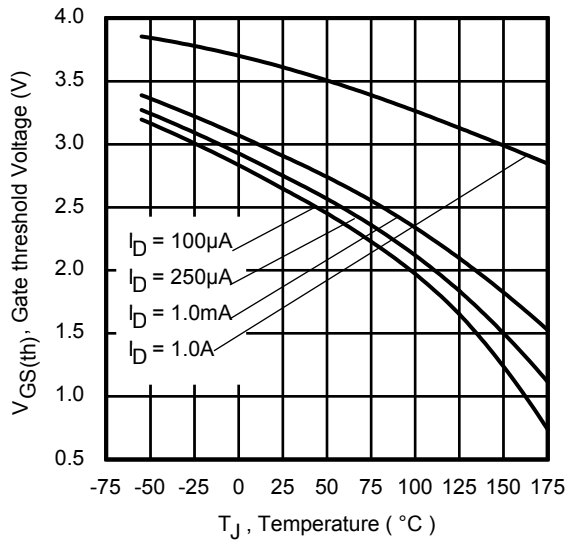
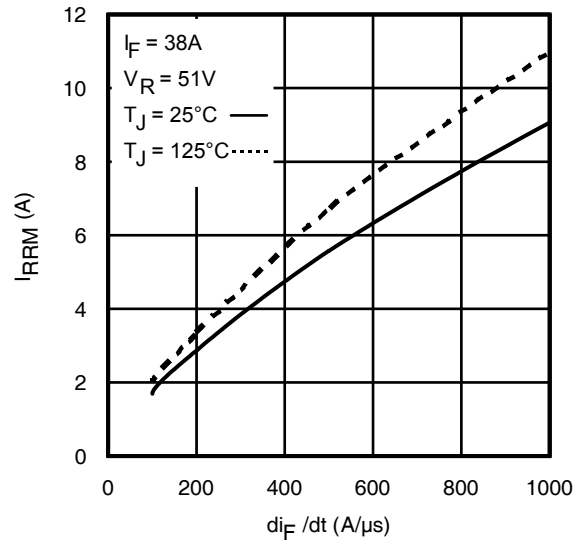
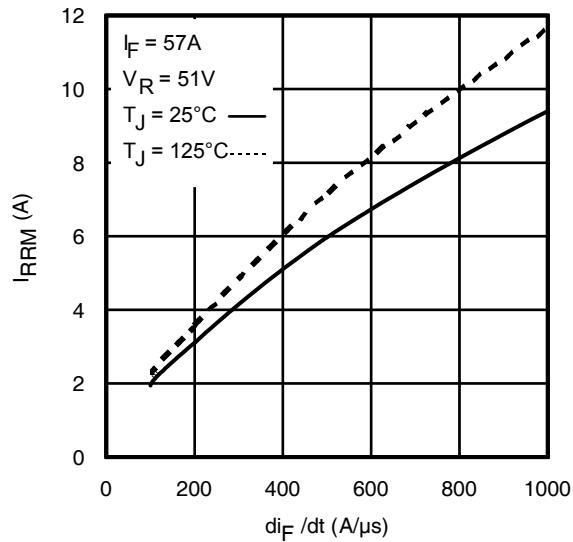
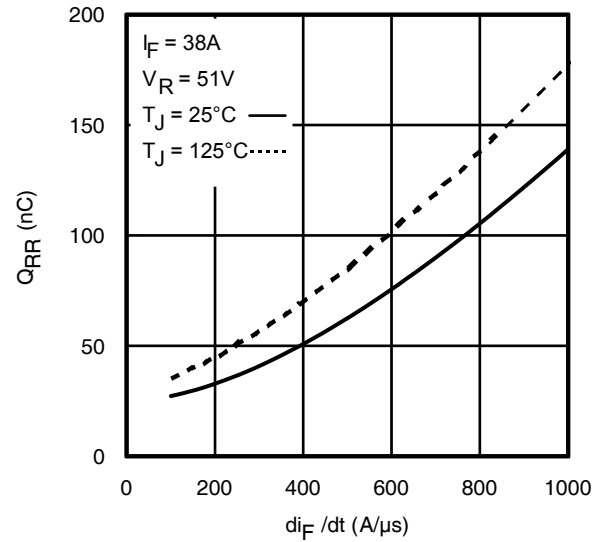
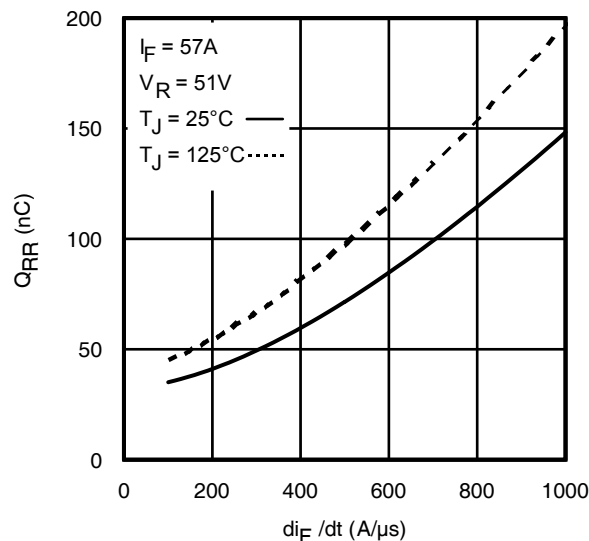

**Fig 3. Typical Output Characteristics**

**Fig 4. Typical Output Characteristics**

**Fig 5. Typical Transfer Characteristics**

**Fig 6. Normalized On-Resistance vs. Temperature**

**Fig 7. Typical Capacitance vs. Drain-to-Source Voltage**

**Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage**

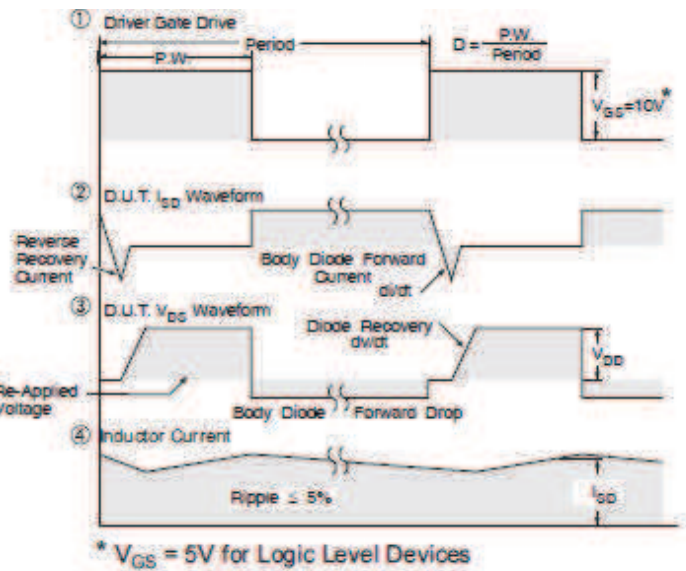
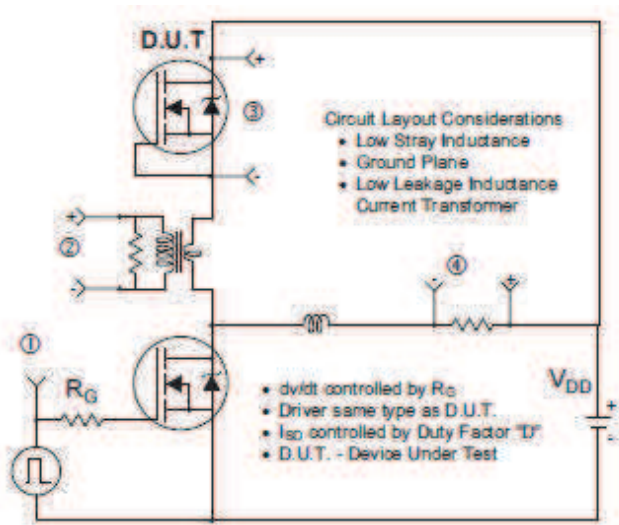

**Fig 9.** Typical Source-Drain Diode Forward Voltage

**Fig 10.** Maximum Safe Operating Area

**Fig 11.** Drain-to-Source Breakdown Voltage

**Fig 12.** Typical  $C_{oss}$  Stored Energy

**Fig 13.** Typical On-Resistance vs. Drain Current


**Fig 14.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

**Fig 15.** Avalanche Current vs. Pulse Width

**Fig 16.** Maximum Avalanche Energy vs. Temperature

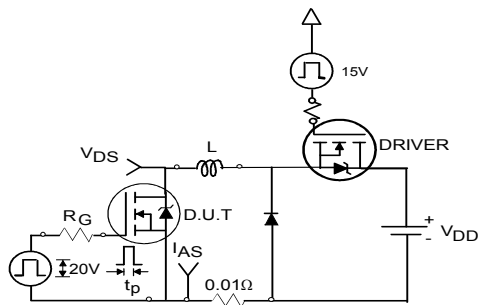
**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
**(For further info, see AN-1005 at www.irf.com)**

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)  
 $P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$   
 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$   
 $E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$

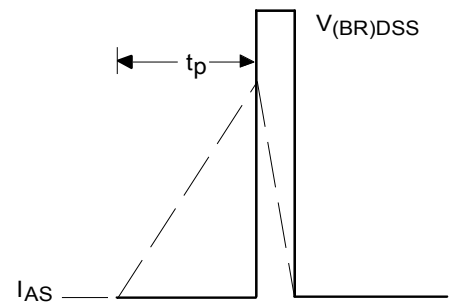

**Fig 17.** Threshold Voltage vs. Temperature

**Fig 18.** Typical Recovery Current vs.  $di_F/dt$ 

**Fig 19.** Typical Recovery Current vs.  $di_F/dt$ 

**Fig 20.** Typical Stored Charge vs.  $di_F/dt$ 

**Fig 21.** Typical Stored Charge vs.  $di_F/dt$



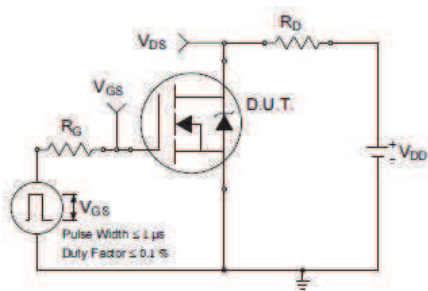
**Fig 22.** Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



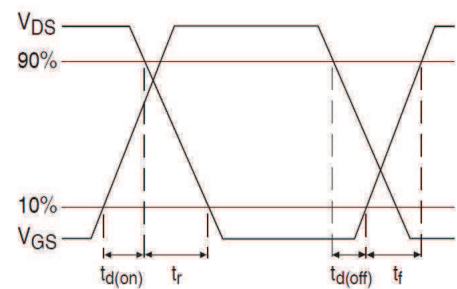
**Fig 23a.** Unclamped Inductive Test Circuit



**Fig 23b.** Unclamped Inductive Waveforms



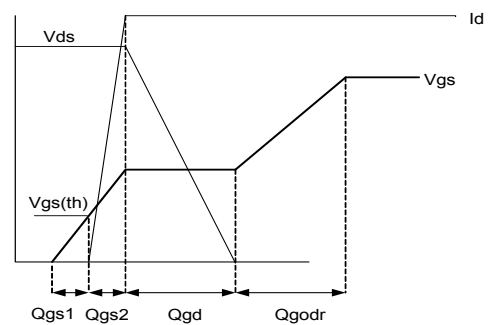
**Fig 24a.** Switching Time Test Circuit



**Fig 24b.** Switching Time Waveforms

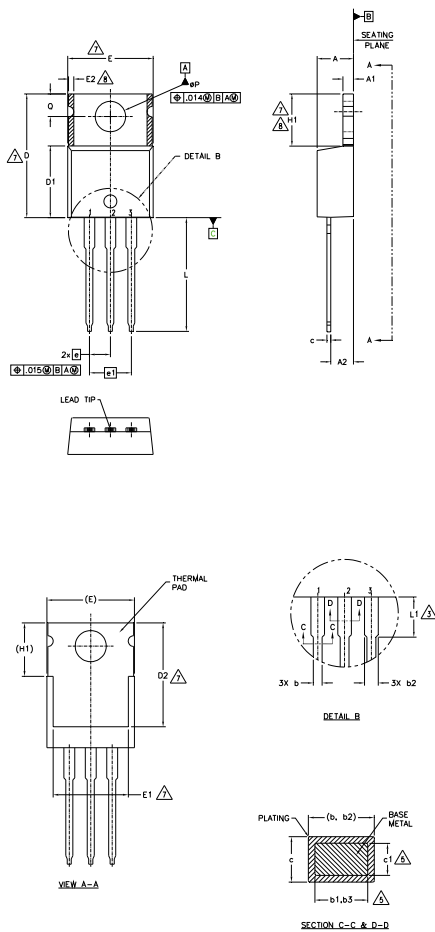


**Fig 25a.** Gate Charge Test Circuit



**Fig 25b.** Gate Charge Waveform



**TO-220AB Package Outline (Dimensions are shown in millimeters (inches))**

**NOTES:**

- 1.- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- 2.- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- 3.- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4.- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5.- DIMENSION b1, b3 & c1 APPLY TO BASE METAL ONLY.
- 6.- CONTROLLING DIMENSION : INCHES.
- 7.- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- 8.- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- 9.- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 3.56        | 4.83  | .140     | .190 |       |
| A1     | 1.14        | 1.40  | .045     | .055 |       |
| A2     | 2.03        | 2.92  | .080     | .115 |       |
| b      | 0.38        | 1.01  | .015     | .040 |       |
| b1     | 0.38        | 0.97  | .015     | .038 | 5     |
| b2     | 1.14        | 1.78  | .045     | .070 |       |
| b3     | 1.14        | 1.73  | .045     | .068 | 5     |
| c      | 0.36        | 0.61  | .014     | .024 |       |
| c1     | 0.36        | 0.56  | .014     | .022 | 5     |
| D      | 14.22       | 16.51 | .560     | .650 | 4     |
| D1     | 8.38        | 9.02  | .330     | .355 |       |
| D2     | 11.68       | 12.88 | .460     | .507 | 7     |
| E      | 9.65        | 10.67 | .380     | .420 | 4,7   |
| E1     | 6.86        | 8.89  | .270     | .350 | 7     |
| E2     | -           | 0.76  | -        | .030 | 8     |
| e      | 2.54 BSC    |       | .100 BSC |      |       |
| e1     | 5.08 BSC    |       | .200 BSC |      |       |
| H1     | 5.84        | 6.86  | .230     | .270 | 7,8   |
| L      | 12.70       | 14.73 | .500     | .580 |       |
| L1     | 3.56        | 4.06  | .140     | .160 | 3     |
| ØP     | 3.54        | 4.08  | .139     | .161 |       |
| Q      | 2.54        | 3.42  | .100     | .135 |       |

**LEAD ASSIGNMENTS**
**HEXFET**

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE

**IGBTs, CoPACK**

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER

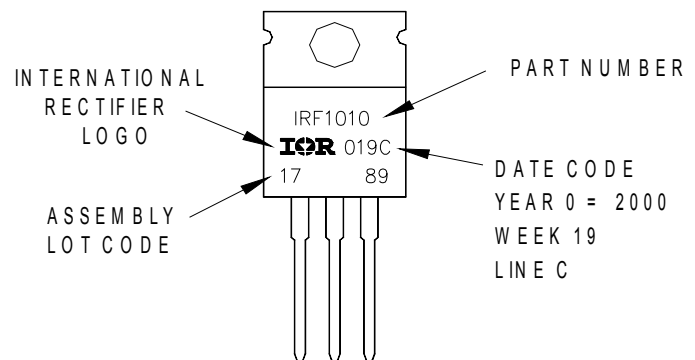
**DIODES**

- 1.- ANODE
- 2.- CATHODE
- 3.- ANODE

**TO-220AB Part Marking Information**

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 2000  
 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position  
 indicates "Lead - Free"



TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Qualification Information<sup>†</sup>**

|                                   |   |     |
|-----------------------------------|---|-----|
| <b>Qualification Level</b>        | Industrial<br>(per JEDEC JESD47F) <sup>††</sup> |     |
| <b>Moisture Sensitivity Level</b> | TO-220  | N/A |
| <b>RoHS Compliant</b>             | Yes   |     |

† Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability/>

†† Applicable version of JEDEC standard at the time of product release.

**Revision History**

| <b>Date</b> | <b>Comment</b>   |
|-------------|--|
| 11/5/2014   | <ul style="list-style-type: none"> <li>• Updated <math>E_{AS (L=1mH)} = 235mJ</math> on page 2</li> <li>• Updated note 8 "Limited by <math>T_{Jmax}</math>, starting <math>T_J = 25^{\circ}C</math>, <math>L = 1mH</math>, <math>R_G = 50\Omega</math>, <math>I_{AS} = 22A</math>, <math>V_{GS} = 10V</math>". on page 2</li> <li>• Updated package outline on page 9</li> </ul> |